Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,367	SAFIAN, JOHN W.	
Examiner	Art Unit	

3754

PHILIPPE S. DERAKSHANI

SEARCHED					
Class	Subclass	Date	Examiner		
222	105 209 385.6 481.5	6/19/2006	PD		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARC	H STRATEGY	′)
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